Search Notes

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YAMADA ET AL.

Applicant(s)/Patent under Reexamination

10/504,815 Examiner

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Class	Subclass	Date	Examiner		
280	755	1/30/2007	П		
74	492	1/30/2007	тт		
74	493	1/30/2007	π		
74	504	1/30/2007	π		
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384	49	1/30/2007	П		
384	- 52	1/30/2007	т		
384	53	1/30/2007	п		
384	54	1/30/2007	П		

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